

SANYO Semiconductors DATA SHEET

N-Channel Silicon MOSFET 2SK4097LS — General-Purpose Switching Device **Applications**

Features

- Low ON-resistance, low input capacitance, ultrahigh-speed switching.
- · Adoption of high reliability HVP process.
- Attachment workability is good by Mica-less package.
- · Avalanche resistance guarantee.

Specifications

Absolute Maximum Ratings at Ta=25°C

Parameter	Symbol	Conditions	Ratings	Unit
Drain-to-Source Voltage	VDSS		500	V
Gate-to-Source Voltage	VGSS		±30	V
Drain Current (DC)	I _{Dc} *1	Limited only by maximum temperature	9.5	А
	IDpack*2	SANYO's ideal heat dissipation condition	8.3	Α
Drain Current (Pulse)	IDP	PW≤10μs, duty cycle≤1%	38	Α
Allowable Power Dissipation	Po		2.0	W
	PD	Tc=25°C (SANYO's ideal heat dissipation condition)	35	W
Channel Temperature	Tch		150	°C
Storage Temperature	Tstg		-55 to +150	°C
Avalanche Energy (Single Pulse) *3	EAS		280	mJ
Avalanche Current *4	IAV		9.5	Α

^{*1} Shows chip capability

Marking: K4097

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^{*2} Package limited

^{*3} V_{DD} =99V, L=5mH, I_{AV} =9.5A

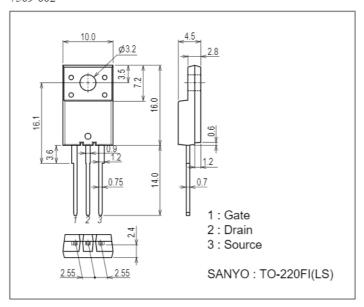
^{*4} L≤5mH, single pulse

Electrical Characteristics at Ta=25°C

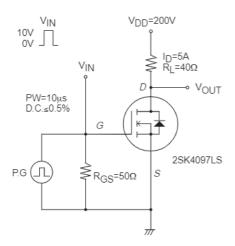
Parameter	Symbol	Conditions	Ratings			Unit
			min	typ	max	Offic
Drain-to-Source Breakdown Voltage	V(BR)DSS	ID=10mA, VGS=0V	500			V
Zero-Gate Voltage Drain Current	IDSS	V _{DS} =400V, V _{GS} =0V			100	μΑ
Gate-to-Source Leakage Current	IGSS	V _{GS} =±30V, V _{DS} =0V			±100	nΑ
Cutoff Voltage	V _{GS} (off)	V _{DS} =10V, I _D =1mA	3		5	V
Forward Transfer Admittance	yfs	V _{DS} =10V, I _D =5A	3	6		S
Static Drain-to-Source On-State Resistance	R _{DS} (on)	I _D =5A, V _{GS} =10V		0.5	0.65	Ω
Input Capacitance	Ciss	V _{DS} =30V, f=1MHz		750		pF
Output Capacitance	Coss	V _{DS} =30V, f=1MHz		150		pF
Reverse Transfer Capacitance	Crss	VDS=30V, f=1MHz		35		pF
Turn-ON Delay Time	t _d (on)	See specified Test Circuit.		16		ns
Rise Time	t _r	See specified Test Circuit.		44		ns
Turn-OFF Delay Time	t _d (off)	See specified Test Circuit.		102		ns
Fall Time	tf	See specified Test Circuit.		47		ns
Total Gate Charge	Qg	V _{DS} =200V, V _{GS} =10V, I _D =9.5A		30		nC
Gate-to-Source Charge	Qgs	V _{DS} =200V, V _{GS} =10V, I _D =9.5A		5.2		nC
Gate-to-Drain "Miller" Charge	Qgd	V _{DS} =200V, V _{GS} =10V, I _D =9.5A		17		nC
Diode Forward Voltage	VsD	IS=9.5A, VGS=0V		0.9	1.2	V

Package Dimensions

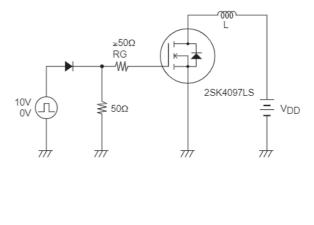
unit : mm (typ) 7509-002

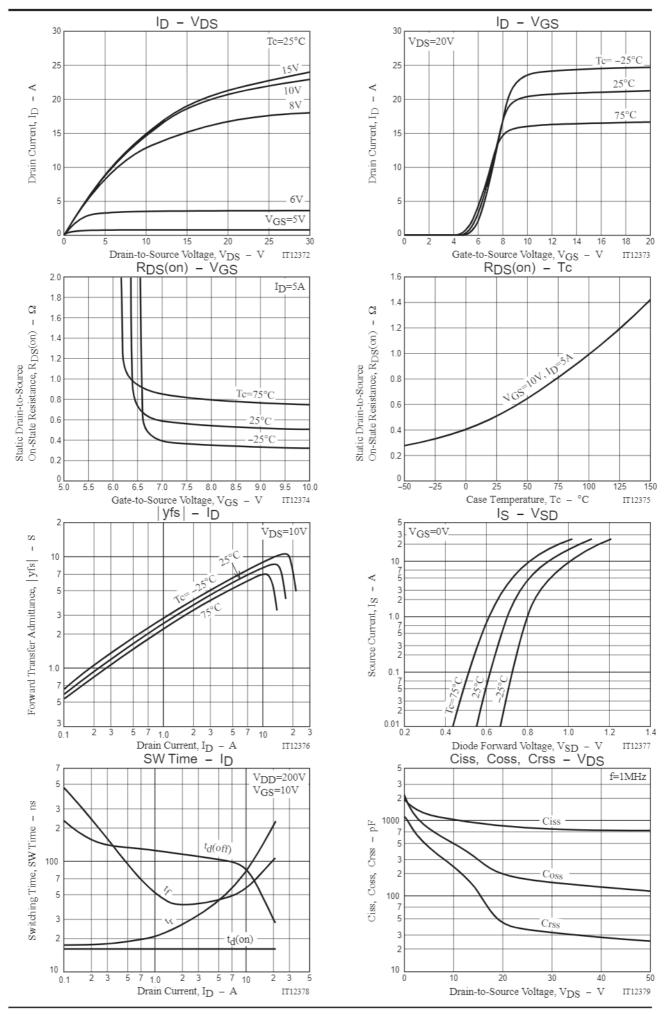


Switching Time Test Circuit

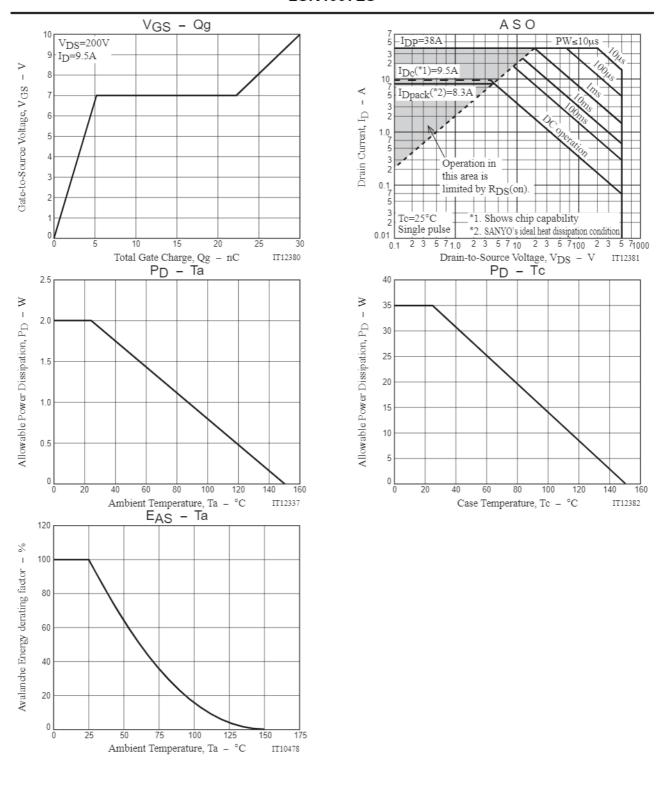


Avalanche Resistance Test Circuit





2SK4097LS



Note on usage: Since the 2SK4097LS is a MOSFET product, please avoid using this device in the vicinity of highly charged objects.

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